'IAP12 Rec'd PCT/PTO 20 DEC 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Atty. Docket

ALEXEI MAZNEV

US030190

Serial No.

Group Art Unit

Filed: CONCURRENTLY

Ex.

METHOD OF MEASURING SUB-MICRON TRENCH STRUCTURES Commissioner for Patents Alexandria, VA 22313-1450

PRELIMINARY AMENDMENT

Sir:

Prior to calculation of the filing fee and examination, please amend the above-identified application as follows: